

EM-ISight ESD



The **EM-ISight-ESD** is a fully integrated test system designed to measure test subjects exposed to an electrostatic discharge (ESD) source. As an industry-first solution, it enables real-time measurement of certified ESD events across frequency, time, integrated, and spatial fields on devices subjected to controlled ESD events.

APREL supports third-party ESD source generators, providing users with confidence in the accuracy and reliability of high-speed event generation. By developing advanced measurement methodologies to capture ESD events in spatial locations, the system resolves time and frequency data through the integration of high-bandwidth oscilloscopes.

By combining multiple measurement functions into a single capture, the **EM-ISight-ESD** system revolutionizes how EMC engineers conduct ESD measurements, promoting best practices for measurement and circuit design. Designed to support a wide range of test applications, the EM-ISight-ESD is the ultimate solution for near-field analysis.

System Software Windows 10/11 Pro 64 Bit

User friendly GUI that allows for easy setup and data retrieval: Automatic antenna probe movement control synchronized to ESD event: Automatic system control or user definable parametric setup incorporating vision system: Visual display including storage and retrieval of measured results in full 3/4D Data tracking for project improvement/quality control: Importation of previous measurement profiles to track design/quality improvements: Perform EM Test - measurements of (near-field) magnetic fields resultant from an ESD event and near field emissions: Record and plot time domain of and ESD event: Record and plot frequency domain of an ESD event: Record and plot spatial data of and ESD event

Full suite of Near-Field software is included

Applications

Automotive Testing to ISO 10605 Road vehicles: IEC 61000-4-2: LCD/OLED Pannel and Televisions: Industrial Appliances: Home Appliances: Avionics and Radar Systems: Computers and Communication Devices: Medical devices: Electronic Susceptibility: Telecommunication Systems medium scale network equipment, routers, switches, and base stations

Frequency Options

 $\label{eq:decomposition} DC-4GHz\ ESD: 9kHz-6GHz\ Near-Field\ Solution\ ; Fully\ upgradeable\ to\ other\ frequencies$

Measurement Units

Sensitivity ESD: 200V – 8kV contact, 200V – 8kV air, BODE in Fx 20dB decade / Pulse: 0.6nS – 1.0nS Typical (optional of >0.4nS with scope upgrade)

(optional of >0.4ns with scope upgrade)

 $\label{thm:minus} \mbox{Time Domain: Sample rate 20GSs, 4GHz analog BW, min time step 0.05pS / Frequency \& Time: \\$

Simultaneous time capture = 0-200nS, Frequency = 1MHz – 4GHz

Near-Field: dBm; dBuV; dBuA; dBuV/m; V/m; dBuT

Reach and Movement

NO. of axes: 6 (X, Y, Z and θ) Built on Denso RC8 Controller

Typical reach*: Along X & Y axes: 600 x 600 mm: Along Z axis: 500 mm (Cartesian) Rotation θ axis: 360° Resolution: X and Y axes: 0.02 mm (upgrade to 0.01 mm) Z axis: 0.02 mm (upgrade to 0.01 mm) θ axis: 0.1° :

Vision Calibrated using Vision Plate and VCS

Probe Options

Fully Calibrated & Characterized Vector Probes – Long Probe ESD Hxy, Hxy, Exy, : Hz, Ez 1mm Exy, 2mm Hxy

Standard Options

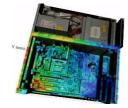
Operating Voltage

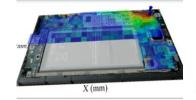
220V AC Robotics: 5V USB Vision System

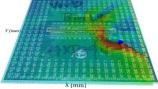
Upgrade Highlights

Far-Field Approximation: Electromagnetic Susceptibility: Multi-Span: Active Phase and Wavefront RF-ISight advanced analysis tool for Import/Export of Simulation data.













EM-ISight-SR

EM-ISight-ER

EM-ISight-LR

EM-ISight-ESD

Available Options				
DC-200MHz Low Frequency Module includes Tesla Field Strength Measurement Function for Battery and Vehicles Includes Hxy/Hz Probe and LNA	·	٠	•	•
10GHz to 72GHz Frequency Option	•	•	•	
10GHz to 110GHz Frequency Option		•	•	
Vector Probes (standard for all XY types)	•	•	•	
Full Probe Rotation 360° (standard)	•	•	•	•
2mm Hxy & Exy Vector Probe (standard)	•	•	•	
2mm Ez (optional)	•	•	•	
2mm Hz (optional)	•		•	
1mm Exy & Hxy Vector Probe (optional)	•	•	•	
1mm Ez (optional)	•		•	
Scan Volume 300 x 300 x 200mm	•	•	•	
Scan Volume 500 x 500 x 400mm			•	
Scan Volume 1,050 x 1,050 x 900mm			•	
Vision System for DUT Capture, Device Teaching and Measurement Parameters (standard)	·	•	٠	٠
Off Axis (horizontal scanning) includes 5 Scanning locations 2 x Horizontal & 3 x Cartesian		•	•	
Far Field Approximation		•	•	•
Ubiquitous Server Module	•	•	•	•
Advanced Measurement Suite Option, Includes Phase, s11/s22, Vector Network Analyser and Multi Span Support for Analysers	·	•	•	•
Active Phase Module, Supports the measurement of digital devices operating in normal conditions, includes Contact Probe and optional Exy/Ez/Hxy/Hz Characterized probes	٠	•	•	٠
RF-ISight Advanced measurement module, Power Density, Poynting Vector, Phase Passive/Active, Wavefront, Vector and Antenna Assessments and Backscatter: Includes Module for Import and Export of Simulation Data	•	٠	·	٠
ESD Measurement Upgrade		•	•	
ESD Launch Pad kit Option, includes probes, contact discharge, air discharge and ESD immunity measurement suite				•
Hearing Aid Compatibility for C63.19 20013 & 2019	•	•	•	·
Modular Workstation Options		·	•	
Mobile Isolation Chamber (shield)	•			
Shielded Enclosure	•	•	•	•
Advanced Device Positioner	•	•	•	·
ESD Extended Ground Plane				·
ESD 61000 workstation and ground plane				•
Calibration set for High frequency, includes horn, MSL and LNA (50-72GHz/50-110GHz)		•	•	
Electromagnetic Susceptibility Measurement Suite Includes 3V/m or 10V/m Support, RF Amplifier, DVM and Ez Probe	·	·	•	•
Extended Maintenance Program (software/hardware) Includes software updates and support beyond first 12 months	·	•	•	•